



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : 10/039,290 Confirmation No.: 8342  
Applicant : ALI SHAKOURI ET AL.  
Title : SUBMICRON THERMAL IMAGING METHOD AND ENHANCED  
RESOLUTION (SUPER-RESOLVED) AC-COUPLED IMAGING FOR  
THERMAL INSPECTION OF INTEGRATED CIRCUITS  
Filed : 01/04/2002  
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Respectfully submitted,

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